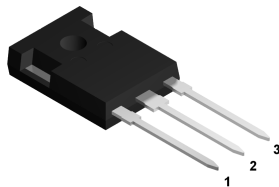
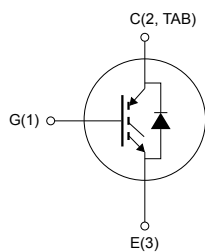


Reverse-conducting 650 V, 50 A, soft-switching IHR series IGBT in a TO-247 long leads package



TO-247 long leads



NG1E3C2T


Product status link
[STGWA50IH65R](#)
Product summary

Order code	STGWA50IH65R
Marking	G50IH65R
Package	TO-247 long leads
Packing	Tube

Features

- Designed for soft-commutation only
- Maximum junction temperature: $T_J = 175\text{ °C}$
- $V_{CE(sat)} = 1.45\text{ V (typ.) @ } I_C = 50\text{ A}$
- Minimized tail current
- Tight parameter distribution
- Low thermal resistance
- Monolithic integrated diode with low voltage drop
- Positive $V_{CE(sat)}$ temperature coefficient

Applications

- Induction cooking
- Resonant converter
- Microwave ovens

Description

The new reverse-conducting IGBT 650 V has been developed using an advanced proprietary trench gate field-stop structure with monolithic integrated body diode, whose performances are optimized both in conduction and switching losses for soft commutation.

The result is a product specifically designed to maximize efficiency for any resonant and soft-switching applications.

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-emitter voltage ($V_{GE} = 0$ V)	650	V
I_C	Continuous collector current at $T_C = 25$ °C	97	A
	Continuous collector current at $T_C = 100$ °C	61	
$I_{CP}^{(1)}$	Pulsed collector current	200	A
V_{GE}	Gate-emitter voltage	±20	V
	Transient gate-emitter voltage ($t_p \leq 10$ µs), $D < 0.01$	±30	
I_F	Continuous forward current at $T_C = 25$ °C	86	A
	Continuous forward current at $T_C = 100$ °C	52	
$I_{FP}^{(1)}$	Pulsed forward current	200	A
P_{TOT}	Total power dissipation at $T_C = 25$ °C	306	W
T_{STG}	Storage temperature range	- 55 to 150	°C
T_J	Operating junction temperature range	- 55 to 175	°C

1. Pulse width limited by maximum junction temperature.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance, junction-to-case, IGBT	0.49	°C/W
	Thermal resistance, junction-to-case, diode	0.7	
R_{thJA}	Thermal resistance, junction-to-ambient	50	°C/W

2 Electrical characteristics

$T_C = 25\text{ °C}$ unless otherwise specified

Table 3. Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage	$V_{GE} = 0\text{ V}$, $I_C = 1\text{ mA}$	650			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}$, $I_C = 50\text{ A}$		1.45	1.75	V
		$V_{GE} = 15\text{ V}$, $I_C = 50\text{ A}$, $T_J = 125\text{ °C}$		1.65		
		$V_{GE} = 15\text{ V}$, $I_C = 50\text{ A}$, $T_J = 175\text{ °C}$		1.75		
V_F	Forward on-voltage	$I_F = 50\text{ A}$		1.45	1.75	V
		$I_F = 50\text{ A}$, $T_J = 125\text{ °C}$		1.50		
		$I_F = 50\text{ A}$, $T_J = 175\text{ °C}$		1.55		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_C = 1\text{ mA}$	4.5	5.5	6.5	V
I_{CES}	Collector cut-off current	$V_{GE} = 0\text{ V}$, $V_{CE} = 650\text{ V}$			25	μA
I_{GES}	Gate-emitter leakage current	$V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$			± 250	nA

Table 4. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	$V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GE} = 0\text{ V}$	-	2949	-	pF
C_{oes}	Output capacitance		-	102	-	pF
C_{res}	Reverse transfer capacitance		-	80	-	pF
Q_g	Total gate charge	$V_{CC} = 520\text{ V}$, $I_C = 50\text{ A}$, $V_{GE} = 0\text{ to }15\text{ V}$ (see Figure 25. Gate charge test circuit)	-	154	-	nC
Q_{ge}	Gate-emitter charge		-	23	-	nC
Q_{gc}	Gate-collector charge		-	77	-	nC

Table 5. IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(off)}$	Turn-off-delay time	$V_{CC} = 400\text{ V}$, $I_C = 50\text{ A}$,	-	177	-	ns
t_f	Current fall time	$V_{GE} = 15\text{ V}$, $R_G = 10\ \Omega$	-	38	-	ns
E_{off}	Turn-off switching energy	(see Figure 23. Test circuit for inductive load switching)	-	736	-	μJ
$t_{d(off)}$	Turn-off-delay time	$V_{CC} = 400\text{ V}$, $I_C = 50\text{ A}$,	-	208	-	ns
t_f	Current fall time	$V_{GE} = 15\text{ V}$, $R_G = 10\ \Omega$, $T_J = 175\text{ °C}$	-	75	-	ns
E_{off}	Turn-off switching energy	(see Figure 23. Test circuit for inductive load switching)	-	1070	-	μJ

Table 6. IGBT switching characteristics (snubbed inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{off}^{(1)}$	Turn-off switching energy	L = 100 μ H, C_{snub} = 22 nF V_{CC} = 400 V, R_G = 10 Ω , I_C = 50 A (see Figure 24. Test circuit for snubbed inductive load switching)	-	236	-	μ J
		L = 100 μ H, C_{snub} = 22 nF, V_{CC} = 400 V, R_G = 10 Ω , I_C = 50 A, T_J = 175 $^{\circ}$ C (see Figure 24. Test circuit for snubbed inductive load switching)	-	474	-	

1. Including the tail of the collector current.

2.1 Electrical characteristics (curves)

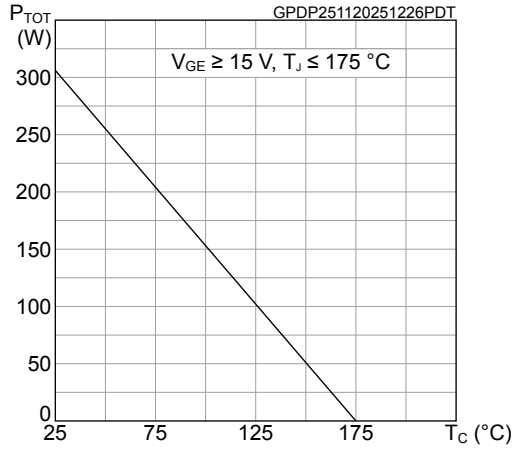
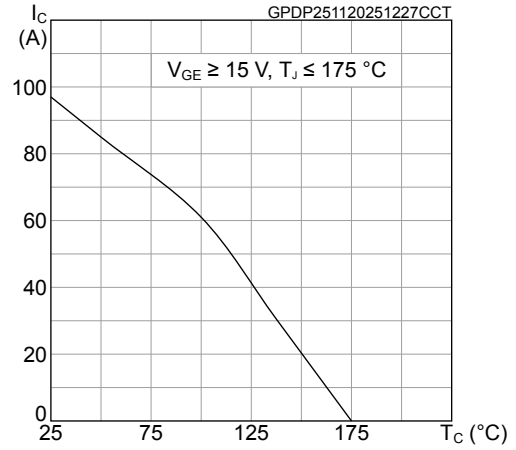
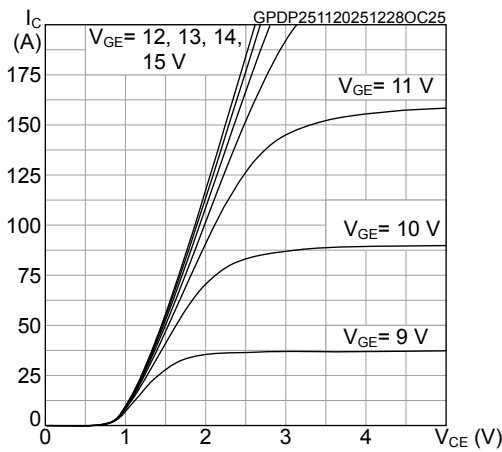
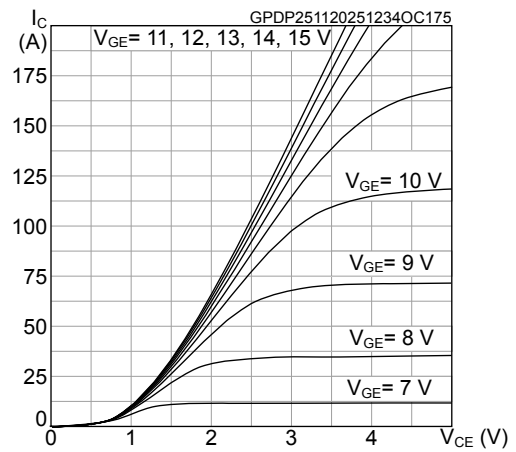
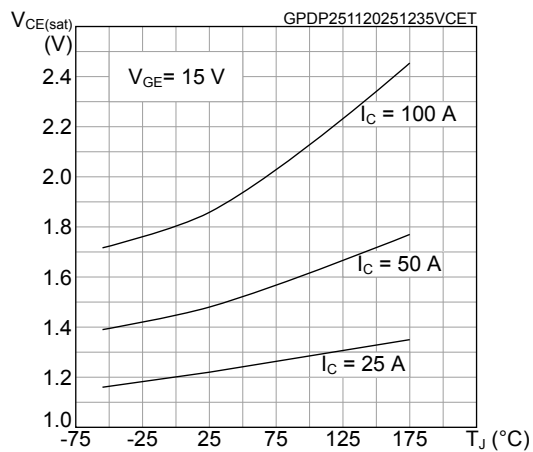
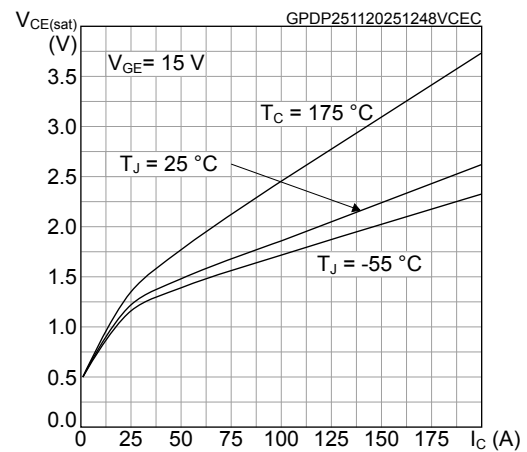
Figure 1. Power dissipation vs case temperature

Figure 2. Collector current vs case temperature

Figure 3. Output characteristics (T_J = 25 °C)

Figure 4. Output characteristics (T_J = 175 °C)

Figure 5. V_{CE(sat)} vs junction temperature

Figure 6. V_{CE(sat)} vs collector current


Figure 7. Forward bias safe operating area

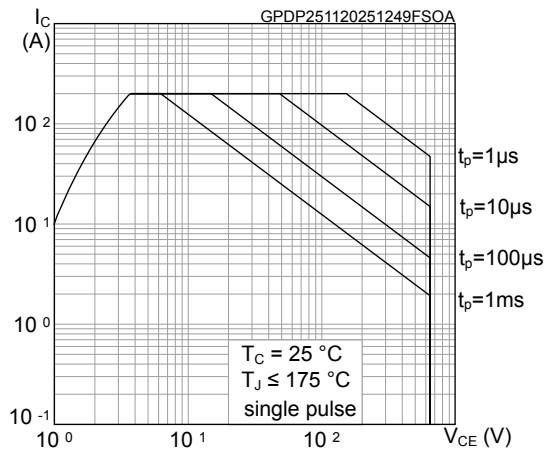


Figure 8. Transfer characteristics

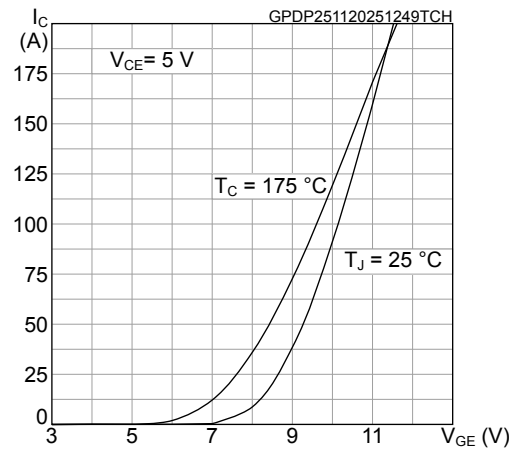


Figure 9. Diode V_F vs forward current

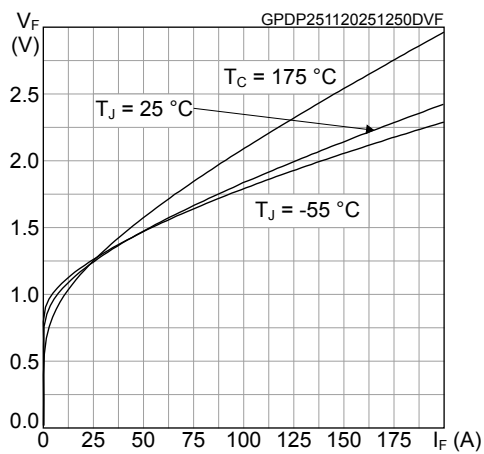


Figure 10. Normalized V_GE(th) vs junction temperature

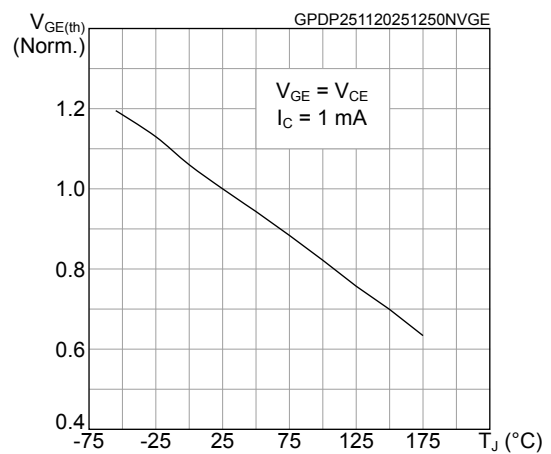


Figure 11. Normalized V_(BR)CES vs junction temperature

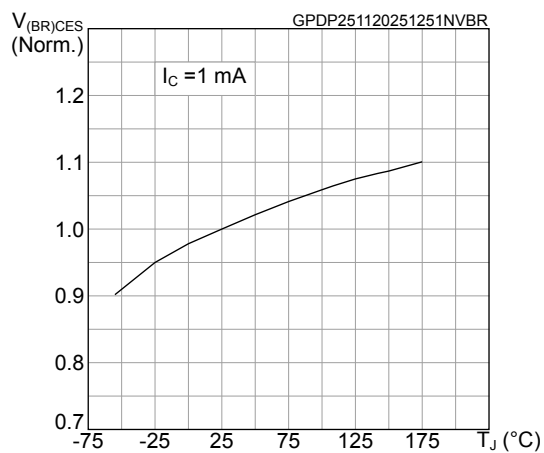


Figure 12. Capacitance variations

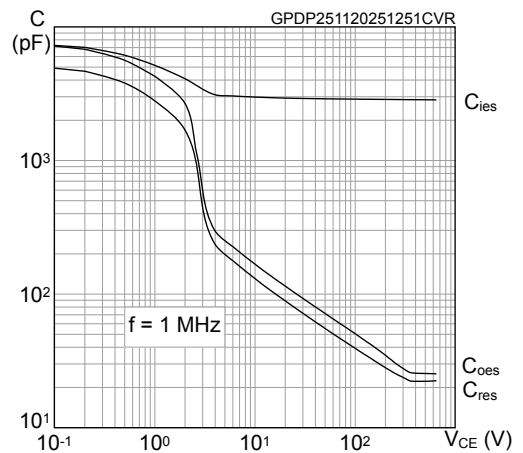


Figure 13. Gate charge vs gate-emitter voltage

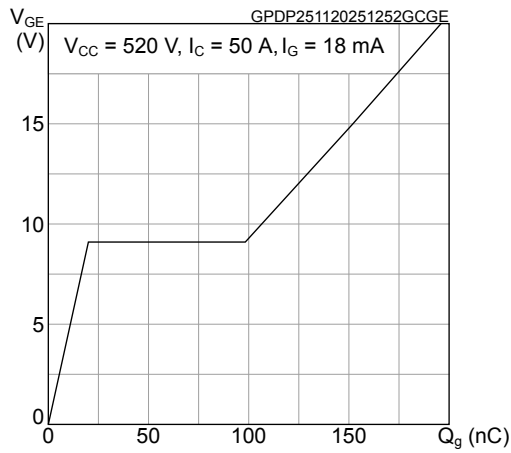


Figure 14. Switching energy vs collector current

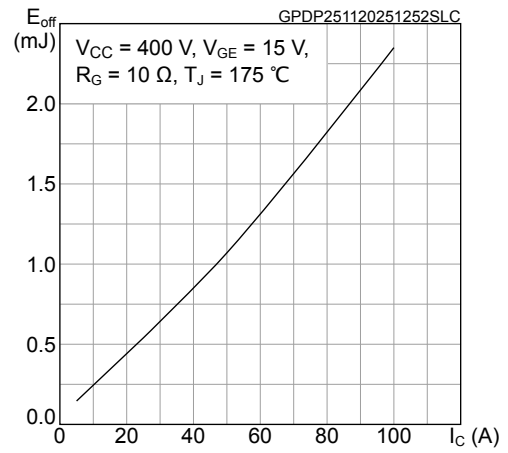


Figure 15. Switching energy vs temperature

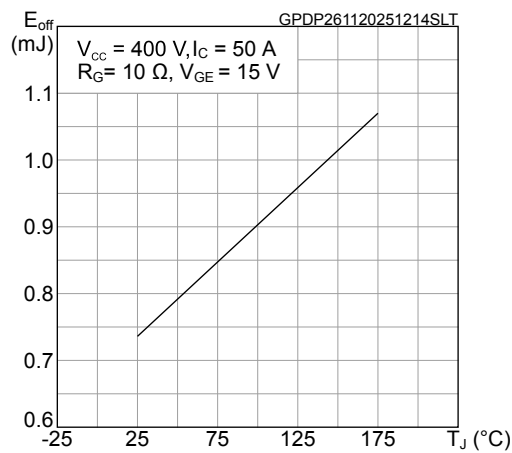


Figure 16. Switching energy vs collector-emitter voltage

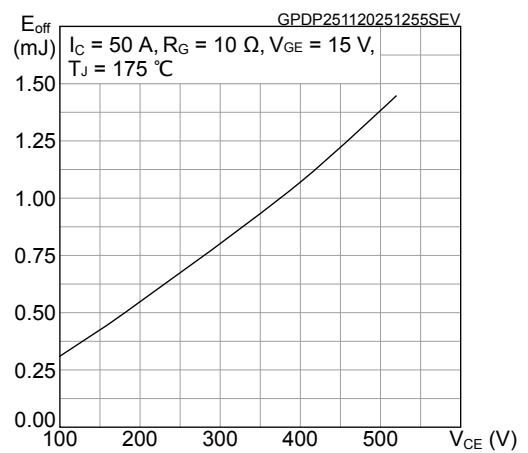


Figure 17. Switching energy vs gate resistance

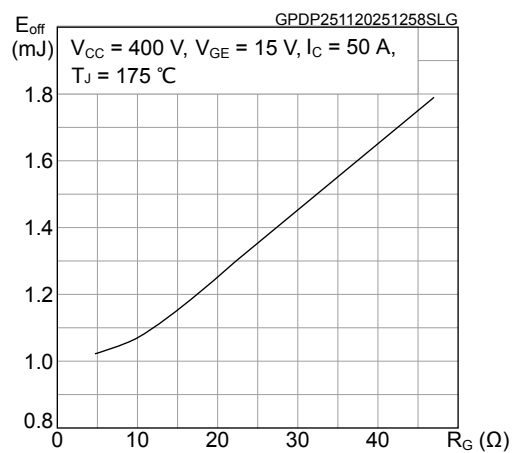


Figure 18. Switching times vs collector current

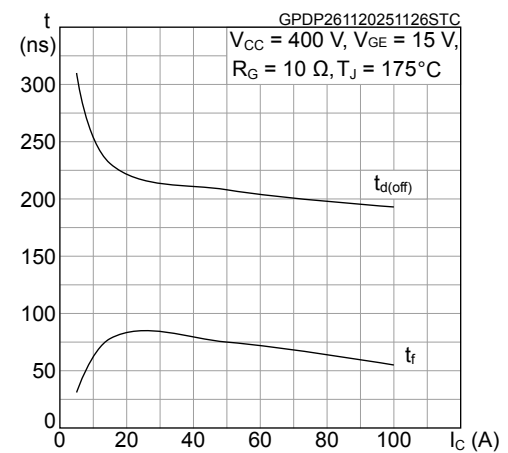


Figure 19. Switching times vs. gate resistance

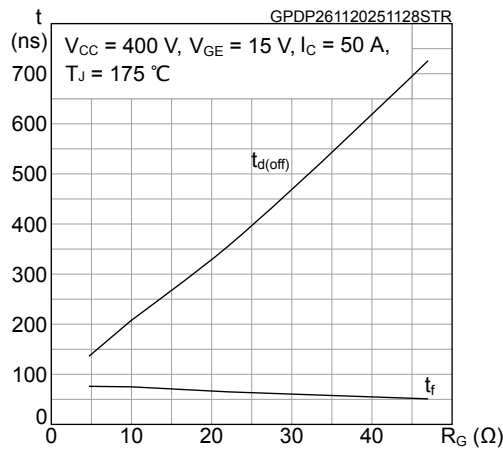


Figure 20. Switching energy vs. snubber capacitance

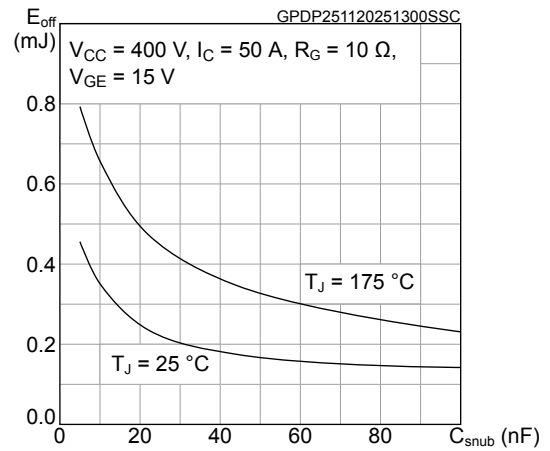


Figure 21. Diode maximum transient thermal impedance

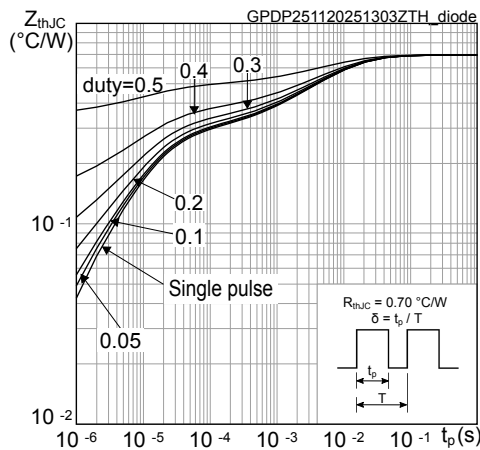
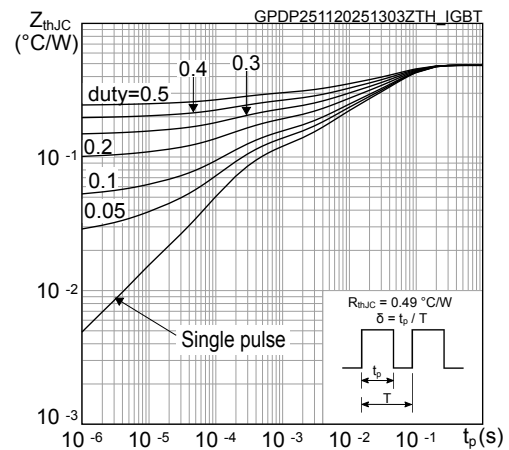


Figure 22. IGBT maximum transient thermal impedance

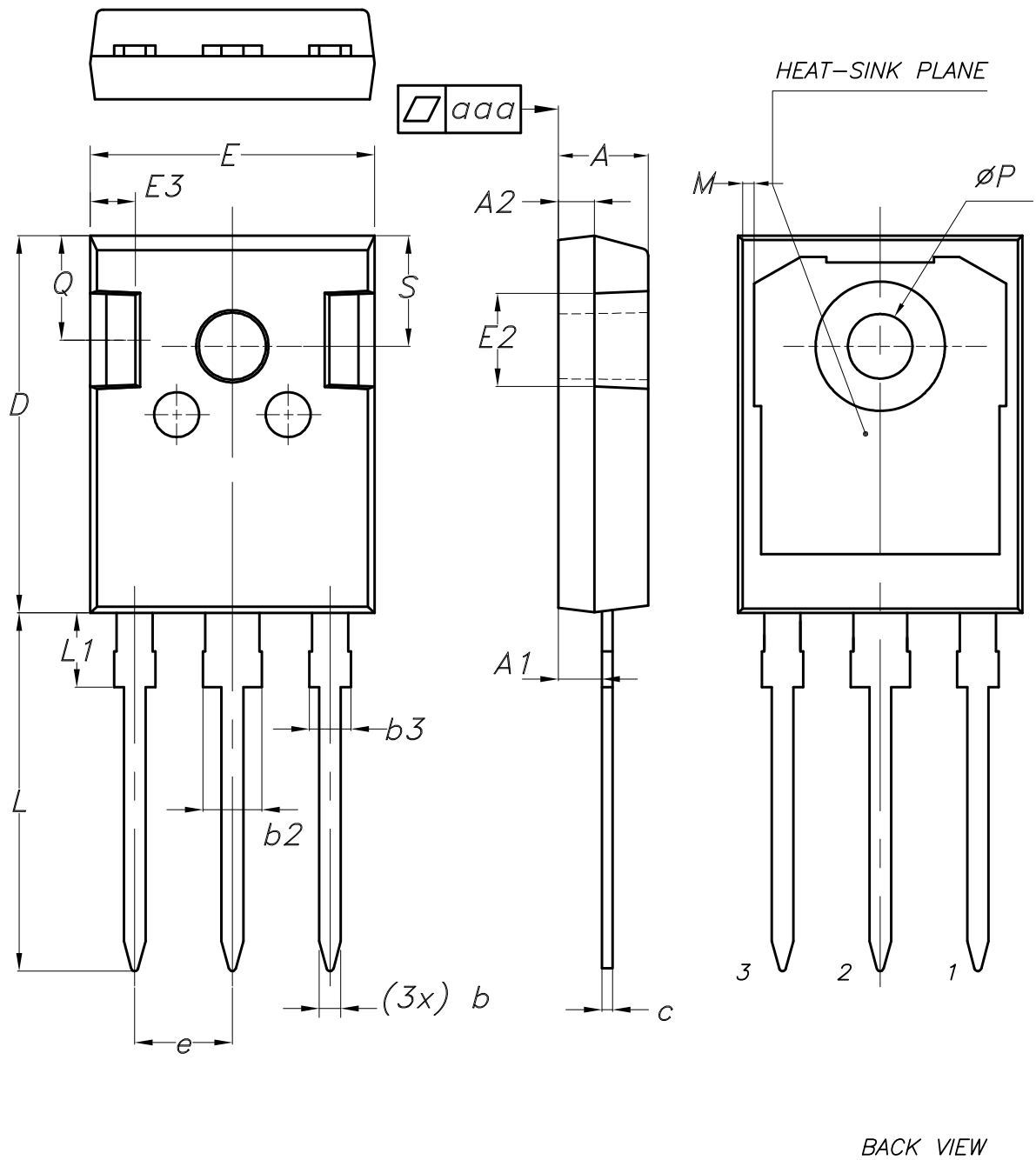


4 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO-247 long leads package information

Figure 27. TO-247 long leads package outline



BACK VIEW

8463846_6

Table 7. TO-247 long leads package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
c	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
M	0.35		0.95
P	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25
aaa		0.04	0.10

Revision history

Table 8. Document revision history

Date	Revision	Changes
01-Dec-2025	1	First release.

Contents

1	Electrical ratings	2
2	Electrical characteristics	3
2.1	Electrical characteristics (curves)	5
3	Test circuits	9
4	Package information	10
4.1	TO-247 long leads package information	10
	Revision history	12

IMPORTANT NOTICE – READ CAREFULLY

STMicroelectronics NV and its subsidiaries (“ST”) reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice.

In the event of any conflict between the provisions of this document and the provisions of any contractual arrangement in force between the purchasers and ST, the provisions of such contractual arrangement shall prevail.

The purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST’s terms and conditions of sale in place at the time of order acknowledgment.

The purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of the purchasers’ products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

If the purchasers identify an ST product that meets their functional and performance requirements but that is not designated for the purchasers’ market segment, the purchasers shall contact ST for more information.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, refer to www.st.com/trademarks. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2025 STMicroelectronics – All rights reserved